

## **RAM Mounts Testing Summary**

## Form-Fit Holder for Getac ZX70

## <u>Products Covered</u> <u>Accompanying Power Supplies</u>

RAM-HOL-GE3FU

RAM-GDS-CHARGE-V10U

RAM-HOL-GE3FKLU

RAM-HOL-GE3NU

RAM-HOL-GE3NKLU



Test	Description
Vibration – operational	MIL-STD-810H, Method 514.8, Table 514.8C-VII, Category 4. Tested performed with unlocked dock and device oriented vertical, transverse, and longitudinal. 1 hour each axis, 3 hours total.
Functional Shock - operational	MIL-STD-810H, Method 516.8, Procedure 1, 3 positive and 3 negative pulses per vertical, longitudinal, and transverse axis. 18 total pulses. Pulses are 20G, 11ms terminal peak sawtooth.
DC Connector – Cycle rating	DC Connector rated and tested to 10k cycles
USB Validation Protocol, Speed, Power	NPI Developed Testing Specification for USB 2.0 Compliance up to 480Mbps, 4.75-5.25VDC @ 900mA per port
Power Supply Input Voltage Tolerance	NPI Developed Testing Specification for Cycle Testing of Input Voltage and variable current
Power Supply Output Voltage Tolerance	NPI Developed Testing Specification for Cycle Testing of Output Voltage and variable current
Power Supply Load Test	NPI Developed Testing Specification for Cycle Testing of Output Voltage and variable current
Regulatory Compliance	FCC, IC CE, RoHS, WEEE
Safety, Emission, Immunity (Ram Power Supply)	CE EN:55032, EN 55035, IEC 61000-6-1, EN 62368-1, e-Mark